

**Search Notes**

Application/Control No.

09/648,590

Examiner

Madeleine AV Nguyen

Applicant(s)/Patent under  
Reexamination

HAMASHIMA ET AL.

Art Unit

2625

**SEARCHED**

Class	Subclass	Date	Examiner
update		4/6/2007	AV

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR